

**Search Notes**

Application/Control No.

10/538,825

Examiner

Derek S. Chapel

Applicant(s)/Patent under  
Reexamination

YE, CHUN

Art Unit

2872

**SEARCHED**

Class	Subclass	Date	Examiner
359	501	6/21/2006	DSC
359	498	6/22/2006	DSC
359	499	6/21/2006	DSC
359	497	6/22/2006	DSC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search, see attached		6/27/2006	DSC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed search, claims, and allowability with Arnel Lavarias	6/27/2006	DSC
EAST Class/Subclass Search: 359/483, 494 and 349/193, 194 (text only, see attached)	6/22/2006	DSC
EAST text search, see attached	6/23/2006	DSC